

## STGYA120M65DF2

# Trench gate field-stop IGBT, M series 650 V, 120 A low loss in a Max247 long leads package

Datasheet - production data

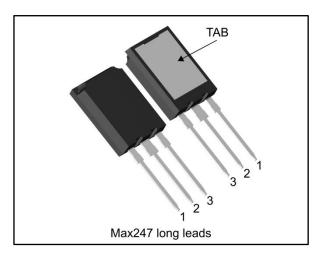
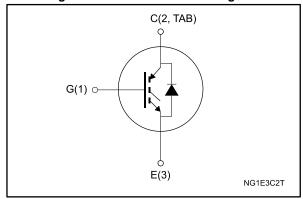


Figure 1: Internal schematic diagram



#### **Features**

- 6 µs of short-circuit withstand time
- V<sub>CE(sat)</sub> = 1.65 V (typ.) @ I<sub>C</sub> = 120 A
- Tight parameter distribution
- Safer paralleling
- Positive V<sub>CE(sat)</sub> temperature coefficient
- Low thermal resistance
- Soft and very fast recovery antiparallel diode
- Maximum junction temperature: T<sub>J</sub> = 175 °C

### **Applications**

- Motor control
- UPS
- PFC
- General purpose inverter

### Description

This device is an IGBT developed using an advanced proprietary trench gate field-stop structure. The device is part of the M series IGBTs, which represent an optimal balance between inverter system performance and efficiency where low-loss and short-circuit functionality are essential. Furthermore, the positive  $V_{\text{CE(sat)}}$  temperature coefficient and tight parameter distribution result in safer paralleling operation.

**Table 1: Device summary** 

Order code	Marking	Package	Packing
STGYA120M65DF2	G120M65DF2	Max247 long leads	Tube

Contents STGYA120M65DF2

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STGYA120M65DF2 Electrical ratings

# 1 Electrical ratings

Table 2: Absolute maximum ratings

Symbol	Parameter	Value	Unit
Vces	Collector-emitter voltage (V <sub>GE</sub> = 0 V)	650	V
Ic <sup>(1)</sup>	Continuous collector current at T <sub>C</sub> = 25 °C 160		Α
lc	Continuous collector current at T <sub>C</sub> = 100 °C 120		A
I <sub>CP</sub> <sup>(2)</sup>	Pulsed collector current	360	Α
$V_{GE}$	Gate-emitter voltage	± 20	V
I <sub>F</sub> <sup>(1)</sup>	Continuous forward current at T <sub>C</sub> = 25 °C	160	Α
l <sub>F</sub>	Continuous forward current at T <sub>C</sub> = 100 °C	120	A
I <sub>FP</sub> <sup>(2)</sup>	Pulsed forward current	360	Α
Ртот	Total dissipation at T <sub>C</sub> = 25 °C		W
T <sub>STG</sub>	Storage temperature range	- 55 to 150	°C
TJ	Operating junction temperature range - 55 to 175		°C

#### Notes:

Table 3: Thermal data

Symbol	Parameter	Value	Unit
R <sub>th</sub> JC	Thermal resistance junction-case IGBT	0.24	
$R_{thJC}$	Thermal resistance junction-case diode	0.6	°C/W
R <sub>thJA</sub>	Thermal resistance junction-ambient	50	

<sup>&</sup>lt;sup>(1)</sup>Current level is limited by bond wires.

 $<sup>\</sup>ensuremath{^{(2)}}\mbox{Pulse}$  width limited by maximum junction temperature.

### 2 Electrical characteristics

 $T_C = 25$  °C unless otherwise specified

**Table 4: Static characteristics** 

Table 4. Otatic Characteristics						
Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
V <sub>(BR)CES</sub>	Collector-emitter breakdown voltage	V <sub>GE</sub> = 0 V, I <sub>C</sub> = 250 μA	650			<b>V</b>
		V <sub>GE</sub> = 15 V, I <sub>C</sub> = 120 A		1.65	2.15	
V <sub>CE(sat)</sub>	V <sub>CE(sat)</sub> Collector-emitter saturation voltage	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 120 A, T <sub>J</sub> = 125 °C		1.95		V
	voltage	V <sub>GE</sub> = 15 V, I <sub>C</sub> = 120 A, T <sub>J</sub> = 175 °C		2.1		
		I <sub>F</sub> = 120 A		1.9	2.6	
VF	Forward on-voltage	I <sub>F</sub> = 120 A, T <sub>J</sub> = 125 °C		1.7		V
		I <sub>F</sub> = 120 A, T <sub>J</sub> = 175 °C		1.6		
V <sub>GE(th)</sub>	Gate threshold voltage	Vce = Vge, Ic = 2 mA	5	6	7	V
Ices	Collector cut-off current	V <sub>GE</sub> = 0 V, V <sub>CE</sub> = 650 V			100	μΑ
Iges	Gate-emitter leakage current	V <sub>CE</sub> = 0 V, V <sub>GE</sub> = ± 20 V			± 250	μΑ

**Table 5: Dynamic characteristics** 

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
C <sub>ies</sub>	Input capacitance		-	11	-	
Coes	Output capacitance	V <sub>CE</sub> = 25 V, f = 1 MHz,	ı	0.61	1	nF
Cres	Reverse transfer capacitance	$V_{GE} = 0 V$	-	0.25	-	
Qg	Total gate charge	Vcc = 520 V, Ic = 120 A,	ı	420	ı	
Qge	Gate-emitter charge	V <sub>GE</sub> = 0 to 15 V (see <i>Figure</i> 30: " <i>Gate charge test</i>	ı	90	ı	nC
Qgc	Gate-collector charge	circuit")	-	160	-	

STGYA120M65DF2 Electrical characteristics

Table 6: IGBT switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>d(on)</sub>	Turn-on delay time			66	-	ns
tr	Current rise time			38	-	ns
(di/dt) <sub>on</sub>	Turn-on current slope	V <sub>CE</sub> = 400 V, I <sub>C</sub> = 120 A,		2500	-	A/µs
t <sub>d(off)</sub>	Turn-off-delay time	$V_{GE} = 400 \text{ V}, 10 = 120 \text{ A},$ $V_{GE} = 15 \text{ V}, R_{G} = 4.7 \Omega$		185	-	ns
t <sub>f</sub>	Current fall time	(see Figure 29: " Test circuit		85	-	ns
E <sub>on</sub> <sup>(1)</sup>	Turn-on switching energy	for inductive load switching")		1.8	-	mJ
E <sub>off</sub> (2)	Turn-off switching energy			4.41	-	mJ
Ets	Total switching energy			6.21	-	mJ
t <sub>d(on)</sub>	Turn-on delay time			62	-	ns
tr	Current rise time			48	-	ns
(di/dt) <sub>on</sub>	Turn-on current slope	$V_{CE} = 400 \text{ V}, \text{ Ic} = 120 \text{ A},$ $V_{GE} = 15 \text{ V}, \text{ Rg} = 4.7 \Omega$		2016	-	A/µs
t <sub>d(off)</sub>	Turn-off-delay time			187	-	ns
tf	Current fall time	T <sub>J</sub> = 175 °C (see Figure 29: " Test circuit for inductive load		164	-	ns
Eon <sup>(1)</sup>	Turn-on switching energy	switching")		4.4	-	mJ
E <sub>off</sub> (2)	Turn-off switching energy			6.0	-	mJ
Ets	Total switching energy			10.4	-	mJ
	Short-circuit withstand time	V <sub>CC</sub> ≤ 400 V, V <sub>GE</sub> = 13 V, T <sub>Jstart</sub> = 150 °C	10			
t <sub>sc</sub>		V <sub>CC</sub> ≤ 400 V, V <sub>GE</sub> = 15 V, T <sub>Jstart</sub> = 150 °C	6		-	μs

#### Notes:

Table 7: Diode switching characteristics (inductive load)

Symbol	Parameter	Test conditions	Min.	Тур.	Max.	Unit
t <sub>rr</sub>	Reverse recovery time		-	202	ı	ns
Qrr	Reverse recovery charge	$I_F = 120 \text{ A}, V_R = 400 \text{ V},$ $V_{GE} = 15 \text{ V},$ $di/dt = 1000 \text{ A/}\mu\text{s}$	-	2.9	ı	μC
I <sub>rrm</sub>	Reverse recovery current		-	32.5	ı	Α
dl <sub>rr</sub> /dt	Peak rate of fall of reverse recovery current during t <sub>b</sub>	verse (see Figure 29: " Test circuit		500	ı	A/µs
Err	Reverse recovery energy		-	500	ı	μJ
t <sub>rr</sub>	Reverse recovery time	1 400 A V 400 V	-	320	ı	ns
Qrr	Reverse recovery charge	I <sub>F</sub> = 120 A, V <sub>R</sub> = 400 V, V <sub>GE</sub> = 15 V ,	-	11.2	ı	μC
I <sub>rrm</sub>	Reverse recovery current	di/dt = 1000 A/µs,	-	62	1	Α
dl <sub>rr</sub> /dt	Peak rate of fall of reverse recovery current during t <sub>b</sub>	T <sub>J</sub> = 175 °C (see Figure 29: " Test circuit for inductive load switching")	-	270	ı	A/µs
Err	Reverse recovery energy		-	1710	•	μJ

<sup>&</sup>lt;sup>(1)</sup>Including the reverse recovery of the diode.

 $<sup>\</sup>ensuremath{^{(2)}}\mbox{Including}$  the tail of the collector current.

### 2.1 Electrical characteristics (curves)

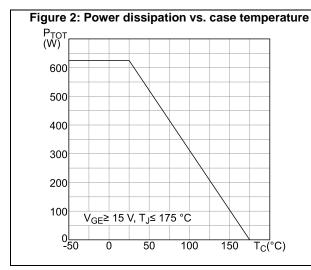
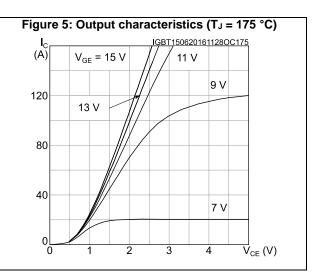
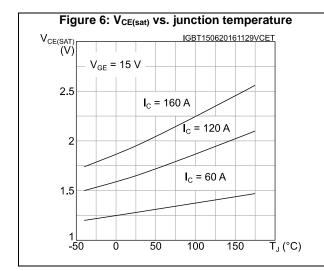


Figure 3: Collector current vs. case temperature  $I_{C}$  (A)  $I_{C}$ 





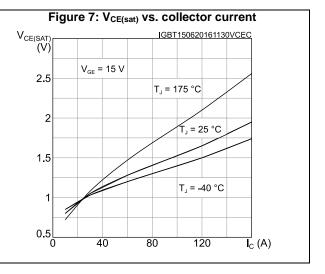


Figure 9: Forward bias safe operating area  $t_{C}(A)$   $10^{2}$   $t_{p} = 10 \text{ µs}$   $t_{p} = 100 \text{ µs}$   $t_{p} = 1 \text{ ms}$   $t_{p} = 10 \text{ ms}$ 

Figure 10: Transfer characteristics

IGHT150620161350TCH

VCE = 6 V

120

T<sub>J</sub> = 25 °C

80

T<sub>J</sub> = 175 °C

0

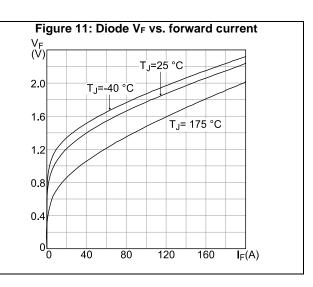
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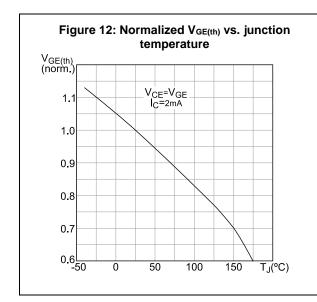
6

7

8

V<sub>GE</sub> (V)





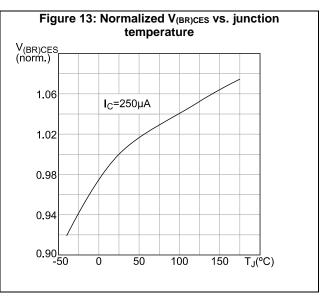


Figure 14: Capacitance variations

C
(pF)

10<sup>4</sup>

10<sup>3</sup>

f = 1 MHz

Coes

Cres

10<sup>1</sup>
10<sup>-1</sup>
10<sup>0</sup>
10<sup>1</sup>
10<sup>2</sup>
VCE(V)

Figure 15: Gate charge vs. gate-emitter voltage

VGE
(V)

VCC= 520 V, IC= 120A, IG= 10 mA

15

10

5

0

100

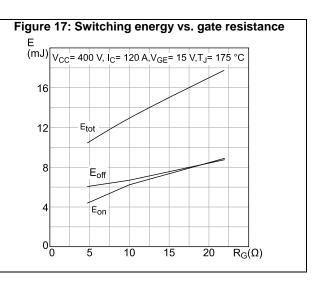
200

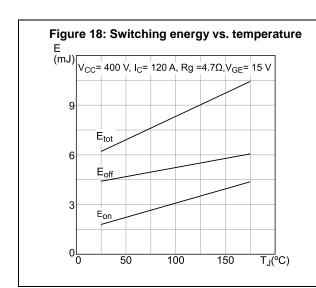
300

400

Qg(nC)

Figure 16: Switching energy vs. collector current  $\begin{array}{c} \text{E} \\ \text{(mJ)} \\ \text{V}_{\text{CC}} = 400 \text{ V}, \\ \text{R}_{\text{G}} = 4.7 \\ \text{\Omega}, \\ \text{V}_{\text{GE}} = 15 \text{ V}, \\ \text{T}_{\text{J}} = 175 \\ \text{°C} \end{array}$ 24 20 16 12  $E_{tot}$ 8 E<sub>off</sub> E<sub>on</sub> o∟ 0 50 100 150 200  $\overline{I_{C}}(A)$ 





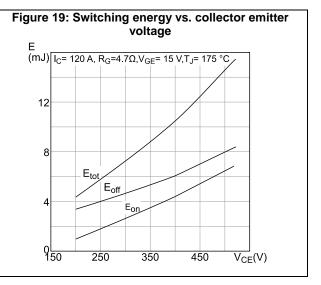
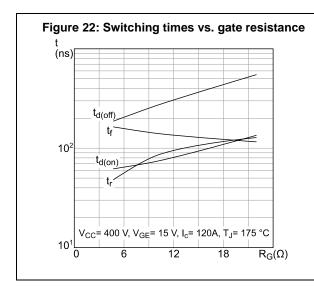
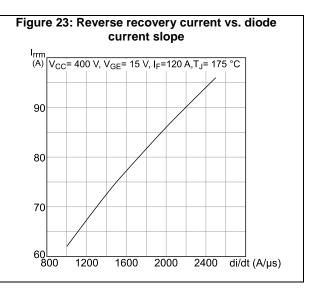
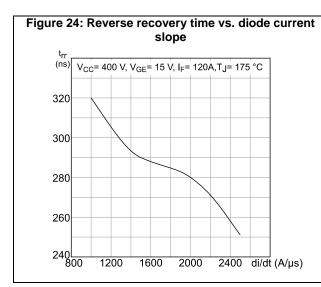


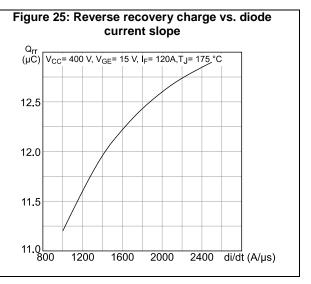
Figure 20: Short circuit time and current vs.  $V_{GE}$   $t_{SC}$   $u_{SC}$   $v_{CC} \le 400 \text{ V}, T_{J} \le 150 \text{ °C}$   $v_{CC} \le 400 \text{ °C}$   $v_{CC}$ 

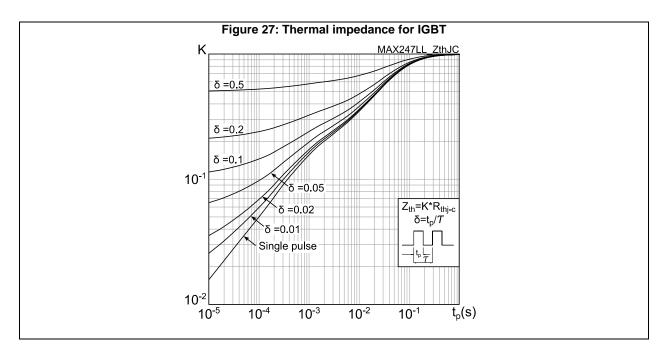
Figure 21: Switching times vs. collector current t (ns)  $V_{CC} = 400 \text{ V}, V_{GE} = 15 \text{ V}, R_G = 4.7\Omega, T_J = 175 °C$   $t_{d(off)}$   $t_f$   $t_{d(on)}$   $t_{d(on$ 

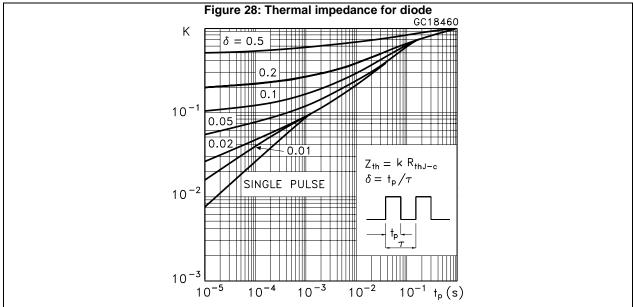






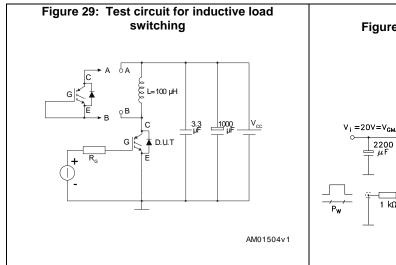


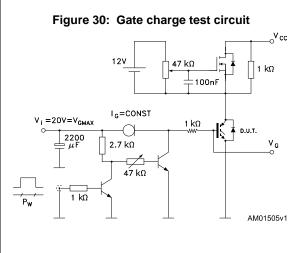


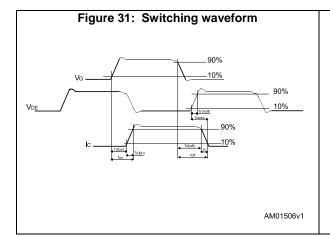


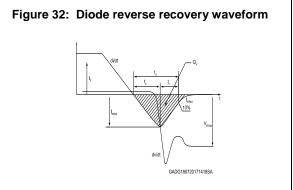
Test circuits STGYA120M65DF2

### 3 Test circuits









# 4 Package information

In order to meet environmental requirements, ST offers these devices in different grades of ECOPACK® packages, depending on their level of environmental compliance. ECOPACK® specifications, grade definitions and product status are available at: **www.st.com**. ECOPACK® is an ST trademark.



# 4.1 Max247 long leads package information

Figure 33: Max247 long leads package outline

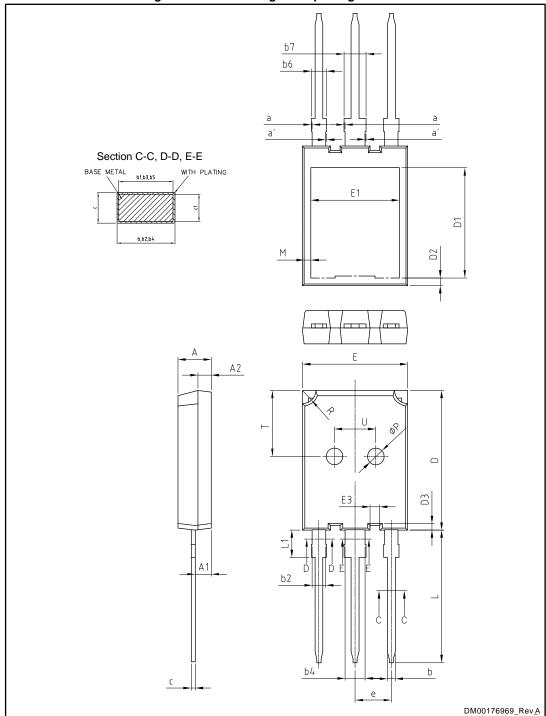


Table 8: Max247 long leads package mechanical data

l able 8: Max247 long leads package mechanical data					
Dim.		mm			
Dilli.	Min.	Тур.	Max.		
А	4.90	5.00	5.10		
A1	2.31	2.41	2.51		
A2	1.90	2.00	2.10		
а	0		0.15		
a'	0		0.15		
b	1.16		1.26		
b1	1.15	1.20	1.22		
b2	1.96		2.06		
b3	1.95	2.00	2.02		
b4	2.96		3.06		
b5	2.95	3.00	3.02		
b6			2.25		
b7			3.25		
С	0.59		0.66		
c1	0.58	0.60	0.62		
D	20.90	21.00	21.10		
D1	16.25	16.55	16.85		
D2	1.05	1.17	1.35		
D3	0.75	1.00	1.25		
Е	15.70	15.80	15.90		
E1	13.10	13.26	13.50		
E3	1.35	1.45	1.55		
е	5.34	5.44	5.54		
L	19.80	19.92	20.10		
L1			4.30		
М	0.70		1.30		
Р	2.40	2.50	2.60		
R	1.90	2.00	2.10		
Т	9.80		10.20		
U	6.00		6.40		

**Revision history** STGYA120M65DF2

#### **Revision history** 5

Table 9: Document revision history

Date	Revision	Changes
06-Apr-2016	1	First release.
10-May-2016	2	Document status promoted to production data.  Added Section 2.1: "Electrical characteristics (curves)"
15-Jun-2016	3	Updated Figure 1: "Internal schematic diagram" and Table 2: "Absolute maximum ratings".  Updated Section 2.1: "Electrical characteristics (curves)".  Minor text changes.
12-Aug-2016	4	Updated <i>Table 7: "Diode switching characteristics (inductive load)"</i> and <i>Figure 25: Reverse recovery charge vs. diode current slope"</i> .  Minor text changes.
13-Sep-2017	5	Updated title, features and application in cover page. Updated Figure 13: "Normalized V(BR)CES vs. junction temperature". Minor text changes.

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